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APPLICATION NO.	FIL	ING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
10/712,333	1	1/13/2003	Kaoru Koike	09792909-5759	1181		
26263	7590	09/28/2005		EXAM	EXAMINER		
SONNENSCHEIN NATH & ROSENTHAL LLP				COLEMAN,	COLEMAN, WILLIAM D		
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DATE MAILED: 09/28/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
	10/712,333	KOIKE ET AL.	
Office Action Summary	Examiner	Art Unit	
	W. David Coleman	2823	
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet w	ith the correspondence address	
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING D. - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period of Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNI 36(a). In no event, however, may a will apply and will expire SIX (6) MOI c, cause the application to become A	CATION. reply be timely filed NTHS from the mailing date of this communic BANDONED (35 U.S.C. § 133).	
Status		·	
1)⊠ Responsive to communication(s) filed on <u>15 Ju</u>	uly 2005.		
2a) ☐ This action is FINAL . 2b) ☑ This	action is non-final.		•
3) Since this application is in condition for allowa	nce except for formal mat	ters, prosecution as to the merit	is is
closed in accordance with the practice under E	Ex parte Quayle, 1935 C.I	D. 11, 453 O.G. 213.	
Disposition of Claims			
4)⊠ Claim(s) <u>1-11 and 39-49</u> is/are pending in the	application.		
4a) Of the above claim(s) is/are withdra	wn from consideration.		
5) Claim(s) is/are allowed.			
6)⊠ Claim(s) <u>1-11 and 39-49</u> is/are rejected.			
7) Claim(s) is/are objected to.			
8) Claim(s) are subject to restriction and/o	or election requirement.		•
Application Papers	•		
9)☐ The specification is objected to by the Examine	er.		
10) The drawing(s) filed on is/are: a) acc			
Applicant may not request that any objection to the			
Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Ex			
Priority under 35 U.S.C. § 119			
12)⊠ Acknowledgment is made of a claim for foreign a)⊠ All b)□ Some * c)□ None of:	n priority under 35 U.S.C.	§ 119(a)-(d) or (f).	
1. Certified copies of the priority document	ts have been received.		
2. Certified copies of the priority document	ts have been received in a	Application No. <u>10/080,104</u> .	
Copies of the certified copies of the prior	· •	n received in this National Stage	;
application from the International Burea			
* See the attached detailed Office action for a list	of the certified copies no	t received.	
		•	
Attachment(s)	Λ <u> </u>	Cummon (DTC 442)	
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No	Summary (PTO-413) (s)/Mail Date	
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	5) Notice of 6) Other:	Informal Patent Application (PTO-152)	

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Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

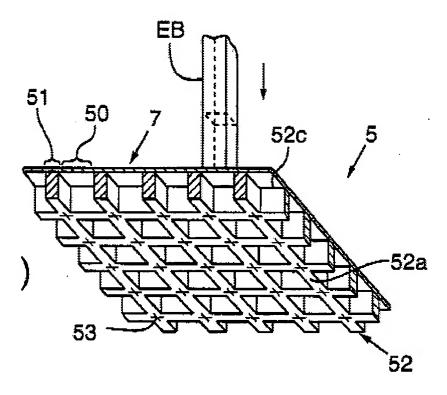
- (e) the invention was described in a patent granted on an application for patent by another filed in the United States before the invention thereof by the applicant for patent, or on an international application by another who has fulfilled the requirements of paragraphs (1), (2), and (4) of section 371(c) of this title before the invention thereof by the applicant for patent.
- 2. The changes made to 35 U.S.C. 102(e) by the American Inventors Protection Act of 1999 (AIPA) and the Intellectual Property and High Technology Technical Amendments Act of 2002 do not apply when the reference is a U.S. patent resulting directly or indirectly from an international application filed before November 29, 2000. Therefore, the prior art date of the reference is determined under 35 U.S.C. 102(e) prior to the amendment by the AIPA (pre-AIPA 35 U.S.C. 102(e)).
- 3. Claims 1-22 are rejected under 35 U.S.C. 102(e) as being anticipated by <u>Yahiro</u> et al., U.S. Patent 6,204,509 B1.

<u>Yahiro</u> discloses the invention as claimed. See FIGS. 1(a)-12, where <u>Yahiro</u> teaches the claimed limitations.

4. Pertaining to claim 1, <u>Yahiro</u> teaches a mask-making member comprising:
a plurality of pattern formation regions 50 in which mask circuit patterns are to be formed; and
a supporting region 51 in which any mask circuit pattern is not to be formed, said supporting
region being provided for holding said plurality of pattern formation regions while separating
said plurality of pattern formation regions from each other;

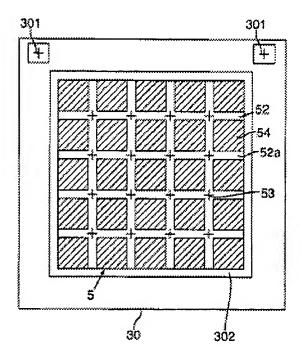
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wherein said supporting region has first alignment marks 53 used at the time of exposure of a mask made from said mask-making member for forming said mask circuit patterns thereon, and second alignment marks 301 used at the time of exposure of a substrate to be exposed for forming circuit patterns thereon.



5. Pertaining to claim 2, <u>Yahiro</u> teaches a mask-making member according to claim 1, wherein said first alignment marks are formed in such a manner that one-or more of said first alignment marks 53 are located in a portion, around each of said plurality of pattern formation regions, of said supporting region, and said second alignment marks 301 are formed in such a manner as to be all located in a portion, outside an area formed by said plurality of said pattern formation regions, of said supporting region.

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- 6. Pertaining to claim 3, <u>Yahiro</u> teaches a mask-making member according to claim 1, wherein shapes of said first alignment marks are different from those of said second alignment marks (please note that the Examiner takes the position that second alignment marks 301 have a rectangular shape around a cross-hair).
- 7. Pertaining to claim 4, <u>Yahiro</u> teaches a mask-making member according to claim 1, wherein said mask making member is a transmission mask-making member (well known when using a electron beam lithography technique).
- 8. Pertaining to claim 5, <u>Yahiro</u> teaches a mask-making member according to claim 1, wherein said mask making member is a stencil mask-making member (please note that the transfer of the image is a stencil type process).

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9. Pertaining to claim 6, <u>Yahiro</u> teaches a mask-making member according to claim 4, wherein said first alignment marks and said second alignment marks are formed on an electron scatterer formed on a membrane.

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- 10. Pertaining to claim 7, <u>Yahiro</u> teaches a mask-making member according to claim 4, wherein said first alignment marks and said second alignment marks are formed on an electron scatterer formed on a membrane by selectively removing said electron scatterer.
- 11. Pertaining to claim 8, <u>Yahiro</u> teaches a mask-making member according to claim 5, wherein said first alignment marks and said second alignment marks are formed on a mask board.
- 12. Pertaining to claim 9, <u>Yahiro</u> teaches a mask-making member according to claim 5, wherein said first alignment marks and said second alignment marks are formed on a mask board by selectively removing said mask board. (please note that the claims presented are product claims and not process claims and only patentable weight is given to the product).
- 13. Pertaining to claim 10, <u>Yahiro</u> teaches a mask-making member according to claim 5, wherein said first alignment marks and said second alignment marks are formed on a mask board by selectively removing said mask board to form holes or grooves in said mask board, and burying said holes or grooves with a metal

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15.

whose atoms have atomic weights heavier than those of atoms of said mask board (please see the reasoning to the rejection of claim 9 above).

14. Pertaining to claim 11, <u>Yahiro</u> teaches a mask-making member according to claim 10, wherein said metal is platinum, gold, silver, copper, tungsten, tantalum, or molybdenum (column 8, line 18).

a plurality of pattern formation regions in which mask circuit patterns are formed; and a supporting region in which any mask circuit pattern is not formed, said supporting region being provided for holding said plurality of pattern formation regions while separating said plurality of pattern formation regions from each other; wherein said supporting: region has first alignment

marks used at the time of exposure of said mask for forming said mask circuit patterns thereon,

Pertaining to claim 39, Yahiro teaches a mask comprising:

and second alignment marks used at the time of exposure of a substrate to be exposed for

forming circuit patterns thereon.

16. Pertaining to claim 40, <u>Yahiro</u> teaches a mask according to claim 39, wherein said first alignment marks are formed in such a manner that one or more of said first alignment marks are located in a portion, around each of said plurality of pattern formation regions, of said supporting region, and said second alignment marks are formed in such a manner as to be all located in a

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portion, outside an area formed by said plurality of said pattern formation regions, of said supporting region.

- 17. Pertaining to claim 41, <u>Yahiro</u> teaches a mask according to claim 39, wherein shapes of said first alignment marks are different from those of said second alignment marks.
- 18. Pertaining to claim 42, <u>Yahiro</u> teaches a mask according to claim 39, wherein said mask is a transmission mask.
- 19. Pertaining to claim 43, <u>Yahiro</u> teaches a mask according to claim 39, wherein said mask is a stencil mask.
- 20. Pertaining to claim 44, <u>Yahiro</u> teaches a mask according to claim 42, wherein said first alignment marks and alignment marks and second alignment marks are formed on an electron scatterer formed on a membrane.
- 21. Pertaining to claim 45, <u>Yahiro</u> teaches a mask according to claim 42, wherein said first alignment marks and said second alignment marks are formed on an electron scatterer formed on a membrane by selectively removing said electron scatterer.
- 22. Pertaining to claim 46, <u>Yahiro</u> teaches a mask according to claim 43, wherein said first alignment marks and said second alignment marks are formed on a mask board.

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23. Pertaining to claim 47, Yahiro teaches a mask according to claim 43, wherein said first

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alignment marks and said second alignment marks are formed on a mask board by selectively

removing said mask board.

24. Pertaining to claim 48, Yahiro teaches a mask according to claim 43, wherein said first

alignment marks and said second alignment marks are formed on a mask board by selectively

removing said mask board to form holes or grooves in said mask board, and burying said holes

or grooves with a metal whose atoms have atomic. weights heavier than those of atoms of said

mask board.

25. Pertaining to claim 49, Yahiro teaches a mask according to claim 48, wherein said metal

is platinum, gold, silver, copper, tungsten, tantalum, or molybdenum.

Information Disclosure Statement

26. The listing of references in the specification is not a proper information disclosure

statement. 37 CFR 1.98(b) requires a list of all patents, publications, or other information

submitted for consideration by the Office, and MPEP § 609 A(1) states, "the list may not be

incorporated into the specification but must be submitted in a separate paper." Therefore, unless

the references have been cited by the examiner on form PTO-892, they have not been

considered.

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Drawings

27. Figures 1 and 2 should be designated by a legend such as --Prior Art-- because only that which is old is illustrated. See MPEP § 608.02(g). Corrected drawings in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. The replacement sheet(s) should be labeled "Replacement Sheet" in the page header (as per 37 CFR 1.84(c)) so as not to obstruct any portion of the drawing figures. If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance. Applicants indicated that revised drawings have been submitted, however the Examiner is requesting a resubmission including figure 2.

Double Patenting

- 28. Claim 1 of this application conflict with claim 1 of Application No. 11/103,809. 37

 CFR 1.78(b) provides that when two or more applications filed by the same applicant contain conflicting claims, elimination of such claims from all but one application may be required in the absence of good and sufficient reason for their retention during pendency in more than one application. Applicant is required to either cancel the conflicting claims from all but one application or maintain a clear line of demarcation between the applications. See MPEP § 822.
- 29. A rejection based on double patenting of the "same invention" type finds its support in the language of 35 U.S.C. 101 which states that "whoever invents or discovers any new and useful process ... may obtain a patent therefor ..." (Emphasis added). Thus, the term "same invention," in this context, means an invention drawn to identical subject matter. See *Miller v. Eagle Mfg. Co.*, 151 U.S. 186 (1894); *In re Ockert*, 245 F.2d 467, 114 USPQ 330 (CCPA 1957); and *In re Vogel*, 422 F.2d 438, 164 USPQ 619 (CCPA 1970).

A statutory type (35 U.S.C. 101) double patenting rejection can be overcome by canceling or amending the conflicting claims so they are no longer coextensive in scope. The

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filing of a terminal disclaimer <u>cannot</u> overcome a double patenting rejection based upon 35 U.S.C. 101.

30. Claim 1 is provisionally rejected under 35 U.S.C. 101 as claiming the same invention as that of claim 1 of copending Application No. 11/103,809. This is a <u>provisional</u> double patenting rejection since the conflicting claims have not in fact been patented.

Conclusion

- Any inquiry concerning this communication or earlier communications from the examiner should be directed to W. David Coleman whose telephone number is 571-272-1856.

 The examiner can normally be reached on Monday-Friday 9:00 AM 5:30 PM.
- 32. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri can be reached on 571-272-1855. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.
- Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

W. David Coleman Primary Examiner Art Unit 2823

WDC